## Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	
10/807,714	CHEN ET AL.	
Examiner	Art Unit	
Tuan N. Quach	2893	

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SEARCHED					
Class	Subclass	Date	Examiner		
257	78, 200, 442, 614	12/19/2008	TQ		
257	E21.068	12/19/2008	TQ		
257	E31.008	12/19/2008	TQ		
257	E31.015	12/19/2008	TQ		
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
interference	JSPGPUB - e search - see	12/19/2008	TQ	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
EAST (USPAT; USPGPUB; EPO; JPO; DERWENT; IBMTDB) see search history printout	12/19/2008	τα			
EAST (USPAT; USPGPUB) interence search - see search printout	12/19/2008	то			